SIR WILLIAM DUNN SCHOOL OF PATHOLOGY



BIOLOGICAL ELECTRON MICROSCOPY

Dr Errin Johnson EM Facility Manager





November 19, 2014















Electron microscopes Electromagnetic Lenses

- TEM lenses are electromagnetic, creating precise, circular magnetic fields that manipulate the electron beam, much the same way that optical lenses focus and direct light
- Similarly to optical lenses, electromagnetic lenses are also susceptible to aberrations
 - Chromatic aberration
 - Spherical aberration
 - Astigmatism





ONBI Microscopy Course

November 19, 2014

Page 9



Micron

Micron OXFORD

- EMs have elaborate pumping systems to ensure that the microscope is operated under a high vacuum (10⁻⁴ Pa)
 - Maintains the integrity of the electron beam, as any interaction with gas atoms will cause the beam to scatter
 - Avoids arcing between the cathode and ground (and damage to the filament)

Sir William Dunn School of Pathology









The TEM Contrast

- Contrast is generated by density differences within the sample, just as in LM.
- Darker areas in the image are where few electrons have been transmitted through the sample, due to thickness or high atomic number.









TEM Applications Ultrastructural imaging – Particulate samples



legatively stained virus-like particles (Jenner Institute/E Johnson)



Negatively stained SAS-6 protein WT aggregates, top; Mutant dimers, bottom (M Cottee/E Johnson)



Positively stained amyloid fibrils (E Johnson)







ONBI Microscopy Course November 19, 2014 Page 17

TEM Applications Ultrastructural imaging – Particulate samples





TEM Applications Single particle imaging







Micron OXFORD

ONBI Microscopy Course November 19, 2014 Page 19





TEM Applications Ultrastructural imaging – Cells









ONBI Microscopy Course November 19, 2014 Page 21



TEM Applications Protein localisation



Whole mount immunolabelled Trypanosome cytoskeleton (S Dean, Dunn School)



HEK cells untransfected (left) and transfected (right) with APEX protein tagged to a mitochondrial matrix protein (J Long, Dunn School)



Correlative light & electron microscopy of HEK cells expressing mVenus (E Johnson & R Kaufmann, Micron)







ONBI Microscopy Course November 19, 2014 Page 23







Energy-dispersive x-ray spectroscopy (EDS) allows chemical characterisation of specimens, based on the emission of characteristic x-rays.



Electron energy loss spectroscopy (EELS) measures the amount of energy lost by inelastically scattered electrons as they pass through the sample. The energy loss is element specific.



Unstained mouse pancreas with elemental contrast using EELS, NIH

Micron OXFORD

ONBI Microscopy Course November 19, 2014 Page 26





How the SEM works Signal detection

- Secondary electrons (SEs) provides surface morphology and topology information.
- SEs are captured by the Everhart-Thornley detector



Sample Preparation for SEM Overview

licron

- SEM specimens must be:
 - Well preserved with no surface contamination or damage
 - Stable in the vacuum
 - Conductive

- Composed of high atomic number elements
- The conventional preparation for SEM samples is similar to that for TEM, although the resin and sectioning steps are omitted.
- There are less size restrictions on SEM samples compared to TEM. Some samples (eg: pollen, insects) can be imaged without much sample prep at all.













SEM Applications Topography – Cells



T-cells interacting with a cancer cell (E Johnson, Dunn School)







November 19, 2014 ONBI Microscopy Course Page 33





Micron OXFORD

November 19, 2014

Page 35

ONBI Microscopy Course











